

# Analog Integrated Circuit Design and Applications Spring 2023

## Nonlinearity and Mismatch

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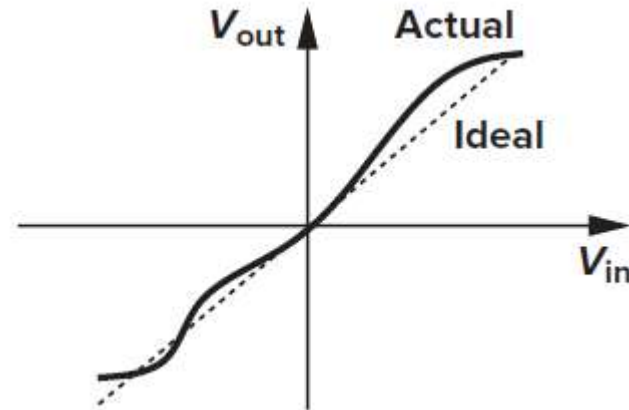
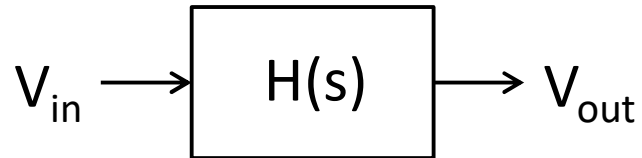
Refer to ch. 14, Razavi's Design of Analog CMOS ICs, 2<sup>nd</sup> ed.

# Outline

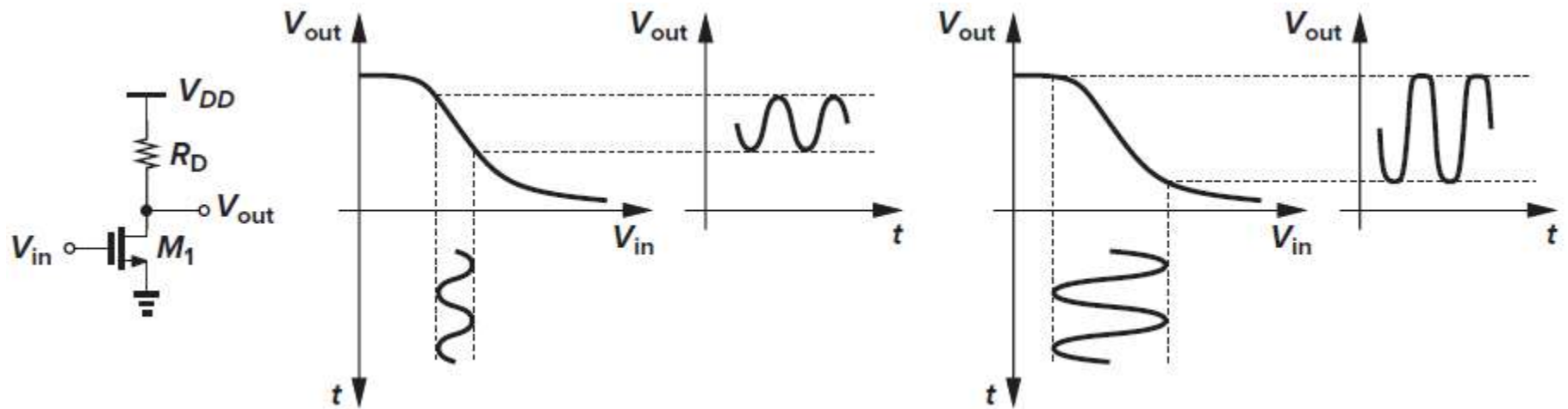
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- Nonlinearity
  - THD: Total Harmonic Distortion
  - Linearization Techniques
- Mismatch
  - Random Mismatch
  - Systematic Mismatch
  - Input-Referred Offset
  - Current Mirror Deviation
  - THD Degradation
- Noise

# Nonlinearity

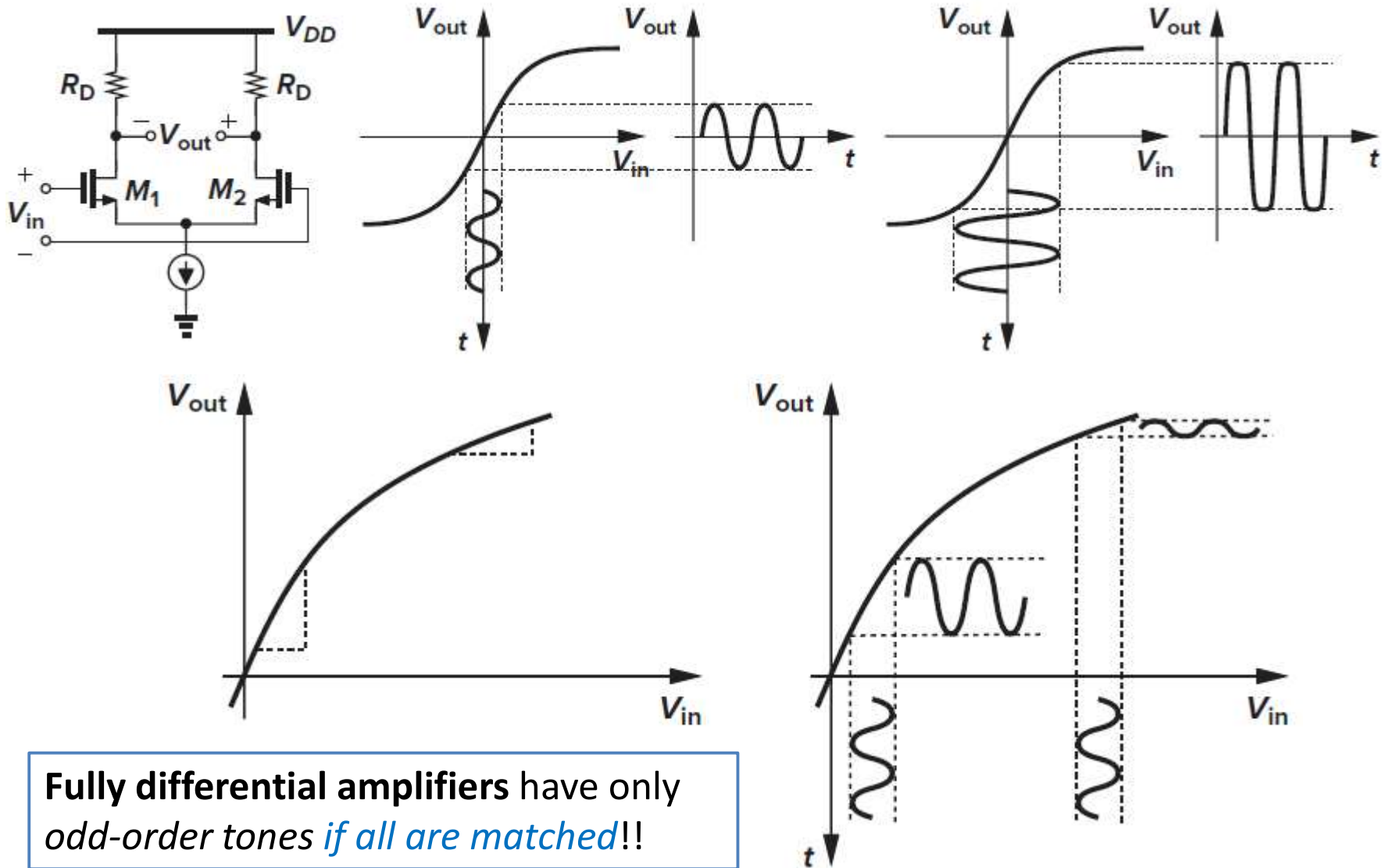


## Single-ended amplifier



- Nonlinearity: the amplifier gain is not constant but varies with the input amplitude

# Nonlinearity



# Total Harmonic Distortion (THD)

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$$y(t) = \alpha_1 x(t) + \alpha_2 x^2(t) + \alpha_3 x^3(t) + \dots$$

Input:  $x(t) = A \cos \omega t$

$$y(t) = \alpha_1 A \cos \omega t + \alpha_2 A^2 \cos^2 \omega t + \alpha_3 \cos^3 \omega t + \dots$$

$$= \alpha_1 A \cos \omega t + \frac{\alpha_2 A^2}{2} [1 + \cos(2\omega t)] + \frac{\alpha_3 A^3}{4} [3 \cos \omega t + \cos(3\omega t)] + \dots$$

$$= \frac{\alpha_2 A^2}{2} + \left( \alpha_1 A + \frac{3\alpha_3 A^3}{4} \right) \cos \omega t + \frac{\alpha_2 A^2}{2} \cos 2\omega t + \frac{\alpha_3 A^3}{4} \cos 3\omega t$$

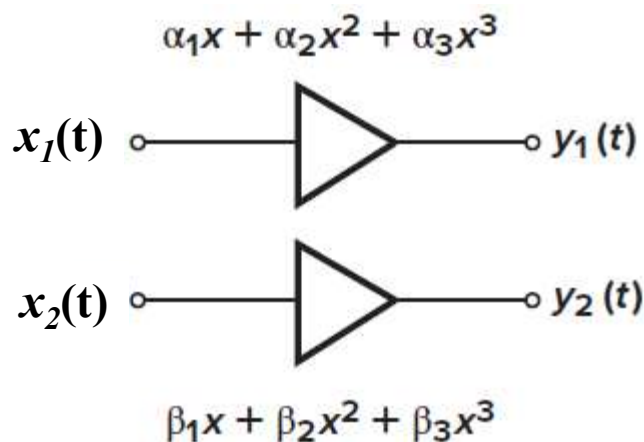
If considering only HD2 and HD3, THD = HD2+HD3 is

Single-ended: 
$$\text{THD} = \frac{(\alpha_2 A^2/2)^2 + (\alpha_3 A^3/4)^2}{(\alpha_1 A + 3\alpha_3 A^3/4)^2}$$

Harmonic distortion is undesirable in most signal processing applications, including audio and video systems. High-quality audio products such as compact disc (CD) players require a THD of about 0.01% (−80 dB), and video products, about 0.1% (−60 dB).

# Distortion of Differential Amplifiers

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$$y_1 - y_2 = (\alpha_1 x_1 - \beta_1 x_2) + (\alpha_2 x_1^2 - \beta_2 x_2^2) + (\alpha_3 x_1^3 - \beta_3 x_2^3)$$

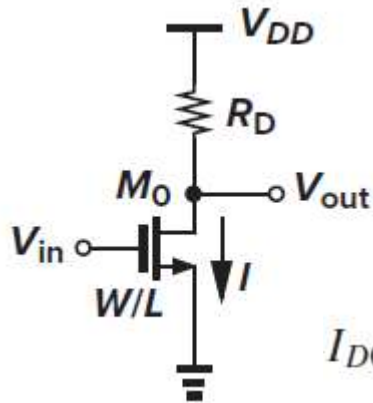
Assume  $x_1 = x$  and  $x_2 = -x$ ,

$$y_d = y_1 - y_2 = (\alpha_1 + \beta_1)x + (\alpha_2 - \beta_2)x^2 + (\alpha_3 + \beta_3)x^3$$

$$\text{if } \alpha_i = \beta_i, \forall i \Rightarrow \underline{y_d = 2\alpha_1 x + 2\alpha_3 x^3}$$

- Single-ended signals have tones of 2<sup>nd</sup>, 3<sup>rd</sup>, 4<sup>th</sup>, ...
- Differential signals only have **odd-order tones, ideally**
- However, the **mismatch** causes even-order tones in differential signals
- In addition, **thermal gradient** also contributes mismatch

# Harmonic Distortion: Single-ended



$$|A_v| \approx g_m R_D$$

$$= \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH}) R_D$$

DC operating point

$$I_{D0} = \frac{1}{2} \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH} + \underbrace{V_m \cos \omega t}_{\text{Input signal}})^2$$

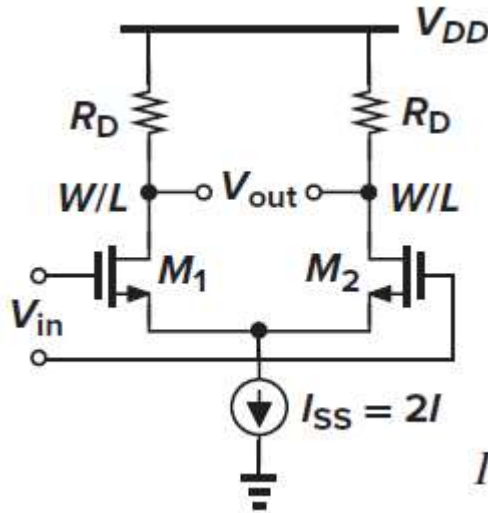
$$= \frac{1}{2} \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH})^2 + \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH}) V_m \cos \omega t + \frac{1}{2} \mu_n C_{ox} \frac{W}{L} V_m^2 \cos^2 \omega t$$

$$= I + \underbrace{\mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH}) V_m \cos \omega t}_{A_F} + \underbrace{\frac{1}{4} \mu_n C_{ox} \frac{W}{L} V_m^2 [1 + \cos(2\omega t)]}_{A_{HD2}}$$

$$\frac{A_{HD2}}{A_F} = \frac{V_m}{4(V_{GS} - V_{TH})}$$

(A very simple version)

# Harmonic Distortion: Differential Pair



$$I_{D1} - I_{D2} = \frac{1}{2} \mu_n C_{ox} \frac{W}{L} V_{in} \sqrt{\frac{4I_{SS}}{\mu_n C_{ox} \frac{W}{L}} - V_{in}^2}$$

(推導見下頁)

$$= \frac{1}{2} \mu_n C_{ox} \frac{W}{L} V_{in} \sqrt{4(V_{GS} - V_{TH})^2 - V_{in}^2}$$

If  $|V_{in}| \ll V_{GS} - V_{TH}$ , then

$$I_{D1} - I_{D2} = \mu_n C_{ox} \frac{W}{L} V_{in} (V_{GS} - V_{TH}) \sqrt{1 - \frac{V_{in}^2}{4(V_{GS} - V_{TH})^2}}$$

$$\approx \mu_n C_{ox} \frac{W}{L} V_{in} (V_{GS} - V_{TH}) \left[ 1 - \frac{V_{in}^2}{8(V_{GS} - V_{TH})^2} \right]$$

$$= \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH}) \left[ V_m \cos \omega t - \frac{V_m^3 \cos^3 \omega t}{8(V_{GS} - V_{TH})^2} \right]$$

$$\cos^3 \omega t = [3 \cos \omega t + \cos(3\omega t)]/4,$$

$$I_{D1} - I_{D2} = g_m \left[ V_m - \frac{3V_m^3}{32(V_{GS} - V_{TH})^2} \right] \cos \omega t - g_m \frac{V_m^3 \cos(3\omega t)}{32(V_{GS} - V_{TH})^2}$$

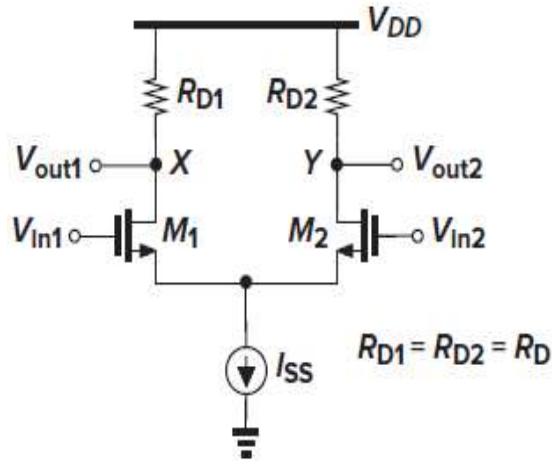
If  $V_m \gg 3V_m^3/[8(V_{GS} - V_{TH})^2]$ , then

$$\frac{A_{HD3}}{A_F} \approx \frac{V_m^2}{32(V_{GS} - V_{TH})^2}$$



# Harmonic Distortion: Differential Pair

$g_m$  vs  $\Delta V_{in}$  推導之補充



$$(V_{GS} - V_{TH})^2 = \frac{I_D}{\frac{1}{2}\mu_n C_{ox} \frac{W}{L}}$$

$$V_{GS} = \sqrt{\frac{2I_D}{\mu_n C_{ox} \frac{W}{L}}} + V_{TH}$$

$$V_{in1} - V_{in2} = \sqrt{\frac{2I_{D1}}{\mu_n C_{ox} \frac{W}{L}}} - \sqrt{\frac{2I_{D2}}{\mu_n C_{ox} \frac{W}{L}}}$$

$$\frac{1}{2}\mu_n C_{ox} \frac{W}{L} (V_{in1} - V_{in2})^2 - I_{SS} = -2\sqrt{I_{D1}I_{D2}}$$

$$= K_n$$

$$\begin{cases} 4I_{D1}I_{D2} = I_{SS}^2 - 2I_{SS}K_n\Delta V_{in}^2 + K_n^2\Delta V_{in}^4, \Delta V_{in} = V_{in1} - V_{in2} \\ 4I_{D1}I_{D2} = (I_{D1} + I_{D2})^2 - (I_{D1} - I_{D2})^2 = I_{SS}^2 - (I_{D1} - I_{D2})^2 \end{cases}$$

$$\begin{aligned} (I_{D1} - I_{D2})^2 &= I_{SS}^2 - 4I_{D1}I_{D2} \\ &= -K_n^2\Delta V_{in}^4 + 2I_{SS}K_n\Delta V_{in}^2 \end{aligned}$$

$$(I_{D1} - I_{D2})^2 = -\frac{1}{4}\left(\mu_n C_{ox} \frac{W}{L}\right)^2 (V_{in1} - V_{in2})^4 + I_{SS}\mu_n C_{ox} \frac{W}{L} (V_{in1} - V_{in2})^2$$

$$I_{D1} - I_{D2} = \frac{1}{2}\mu_n C_{ox} \frac{W}{L} (V_{in1} - V_{in2}) \sqrt{\frac{4I_{SS}}{\mu_n C_{ox} \frac{W}{L}} - (V_{in1} - V_{in2})^2}$$

$$= \sqrt{\mu_n C_{ox} \frac{W}{L} I_{SS}} (V_{in1} - V_{in2}) \sqrt{1 - \frac{\mu_n C_{ox} (W/L)}{4I_{SS}} (V_{in1} - V_{in2})^2}$$

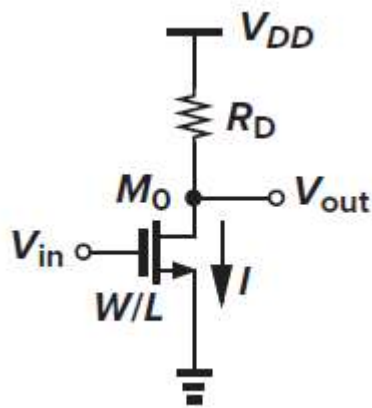
求  $g_m$

$$\frac{\partial \Delta I_D}{\partial \Delta V_{in}} = \frac{1}{2}\mu_n C_{ox} \frac{W}{L} \frac{\frac{4I_{SS}}{\mu_n C_{ox} W/L} - 2\Delta V_{in}^2}{\sqrt{\frac{4I_{SS}}{\mu_n C_{ox} W/L} - \Delta V_{in}^2}}$$

# Harmonic Distortion

if  $V_m = 0.2(V_{GS} - V_{TH})$ ,

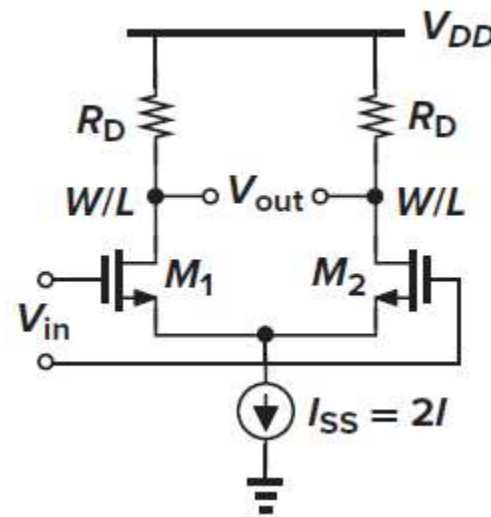
Single-ended



$$\frac{A_{HD2}}{A_F} = \frac{V_m}{4(V_{GS} - V_{TH})}$$

$$= 5\%$$

Fully differential

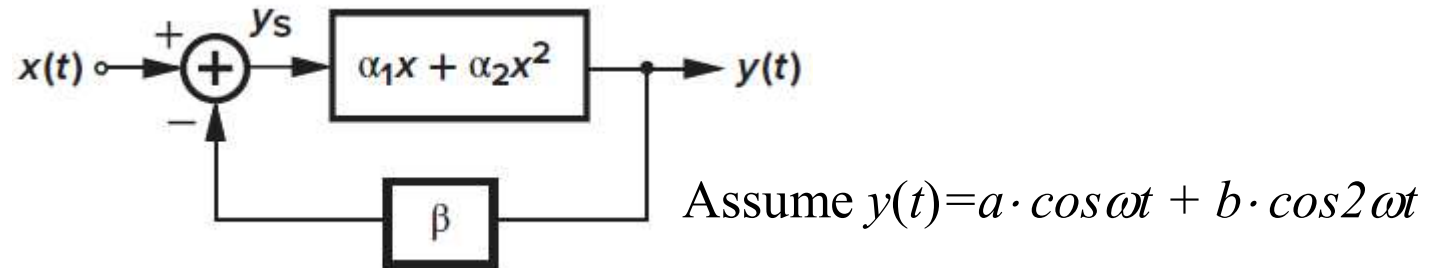


$$\frac{A_{HD3}}{A_F} \approx \frac{V_m^2}{32(V_{GS} - V_{TH})^2}$$

$$= 0.125\%$$

Keep in mind: How to maintain the advantages of fully differential amplifiers?

# Feedback on THD

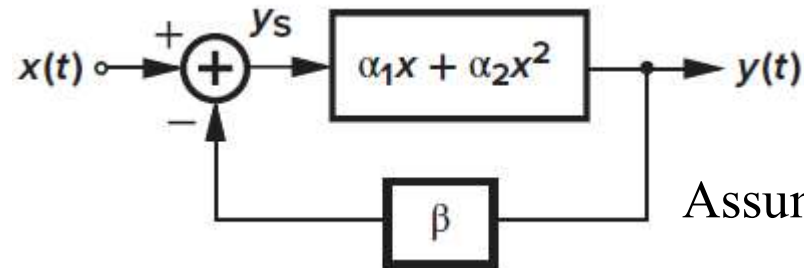


$$\begin{aligned}
 y_s &= x(t) - \beta y(t) \\
 &= V_m \cos \omega t - \beta(a \cos \omega t + b \cos 2\omega t) \\
 &= (V_m - \beta a) \cos \omega t - \beta b \cos 2\omega t
 \end{aligned}$$

$$\begin{aligned}
 y(t) &= \alpha_1 [(V_m - \beta a) \cos \omega t - \beta b \cos 2\omega t] \\
 &\quad + \alpha_2 [(V_m - \beta a) \cos \omega t - \beta b \cos 2\omega t]^2 \\
 &= [\alpha_1 (V_m - \beta a) - \alpha_2 (V_m - \beta a) \beta b] \cos \omega t \\
 &\quad + \left[ -\alpha_1 \beta b + \frac{\alpha_2 (V_m - \beta a)^2}{2} \right] \cos 2\omega t + \dots
 \end{aligned}$$

三角函數

# Feedback on THD



Assume  $y(t) = a \cdot \cos \omega t + b \cdot \cos 2\omega t$

$$y(t) = a \cos(\omega t) + b \cos(2\omega t)$$

$$a = (\alpha_1 - \alpha_2 \beta b)(V_m - \beta a)$$

$$b = -\alpha_1 \beta b + \frac{\alpha_2 (V_m - \beta a)^2}{2}$$

$$a \approx \alpha_1 (V_m - \beta a) \quad \text{If } \alpha_2 \text{ and } b \text{ are small}$$

$$\underline{a = \frac{\alpha_1}{1 + \beta \alpha_1} V_m}$$

To calculate  $b$ , we write

$$V_m - \beta a \approx \frac{a}{\alpha_1}$$

$$b = -\alpha_1 \beta b + \frac{1}{2} \alpha_2 \left( \frac{a}{\alpha_1} \right)^2$$

$$b(1 + \alpha_1 \beta) = \frac{\alpha_2}{2} \left( \frac{a}{\alpha_1} \right)^2$$

$$= \frac{\alpha_2}{2 \alpha_1^2} \frac{\alpha_1^2}{(1 + \beta \alpha_1)^2} V_m^2$$

$$\underline{b = \frac{\alpha_2 V_m^2}{2} \frac{1}{(1 + \beta \alpha_1)^3}}$$

$$\underline{\frac{b}{a} = \frac{\alpha_2 V_m}{2} \frac{1}{\alpha_1} \frac{1}{(1 + \beta \alpha_1)^2}}$$

Improved by feedback

# Linearization Technique (1)

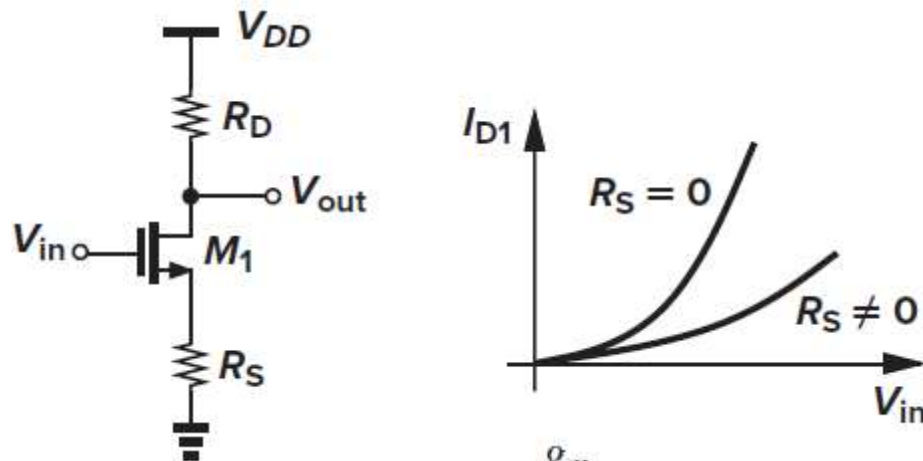
A common-source stage biased at a current  $I_1$  experiences an input voltage swing that varies the drain current from  $0.75I_1$  to  $1.25I_1$ . Calculate the variation of the small-signal voltage gain (a) with no degeneration and (b) with degeneration such that  $g_m R_S = 2$ , where  $g_m$  denotes the transconductance at  $I_D = I_1$ .

[Solution]

Assuming square-law behavior, we have  $g_m \propto \sqrt{I_D}$ . For the case of no degeneration,

$$\frac{g_{m,high}}{g_{m,low}} = \sqrt{\frac{1.25}{0.75}}$$

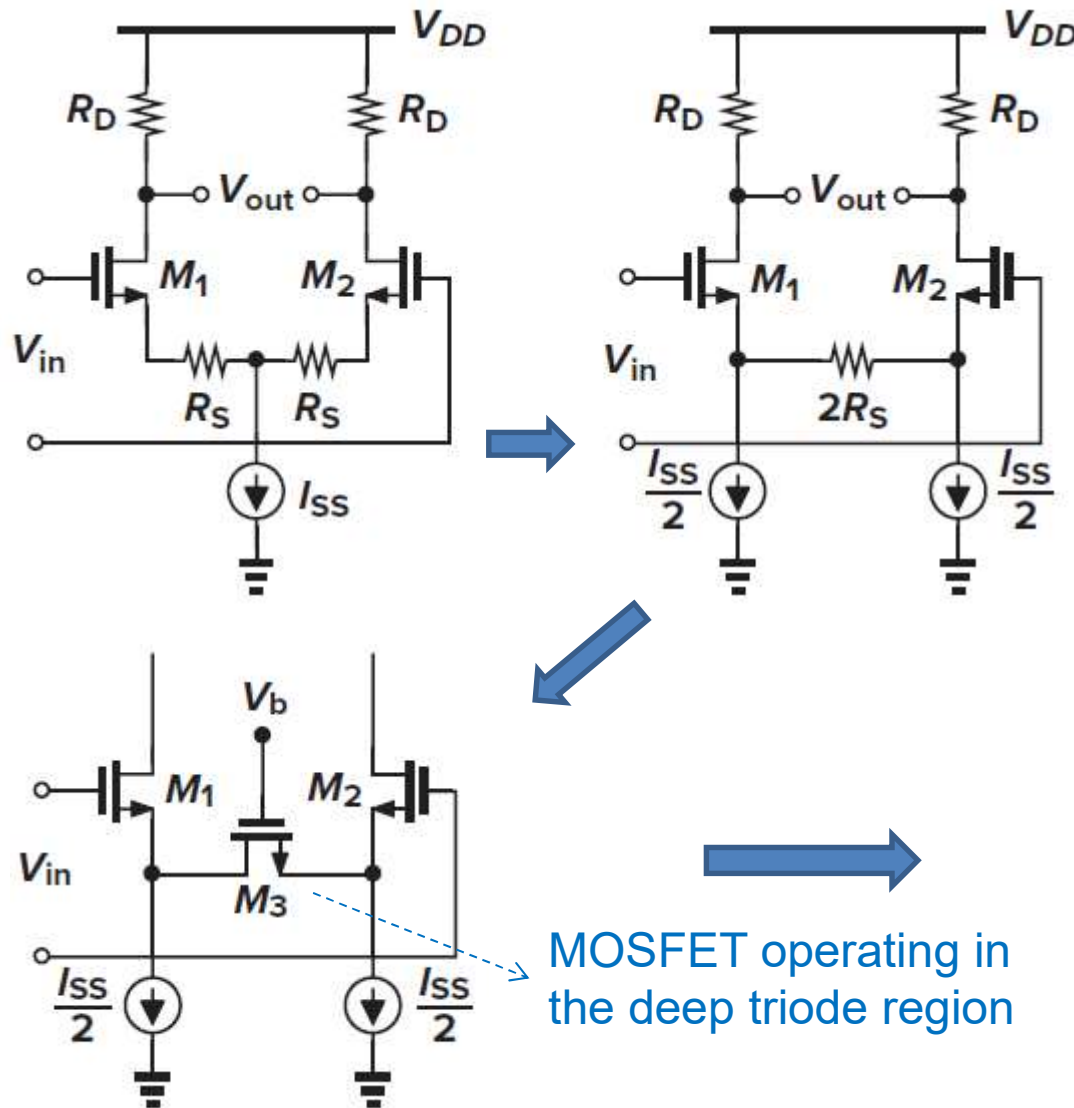
With  $g_m R_S = 2$ , (actually, too small)



$$G_m = \frac{g_m}{1 + g_m R_S}$$

$$\begin{aligned} \frac{G_{m,high}}{G_{m,low}} &= \frac{\frac{\sqrt{1.25}g_m}{1 + \sqrt{1.25}g_m R_S}}{\frac{\sqrt{0.75}g_m}{1 + \sqrt{0.75}g_m R_S}} \\ &= \sqrt{\frac{1.25}{0.75}} \cdot \frac{1 + 2\sqrt{0.75}}{1 + 2\sqrt{1.25}} \\ &= \underline{0.84} \sqrt{\frac{1.25}{0.75}} \end{aligned}$$

# SCP Degeneration



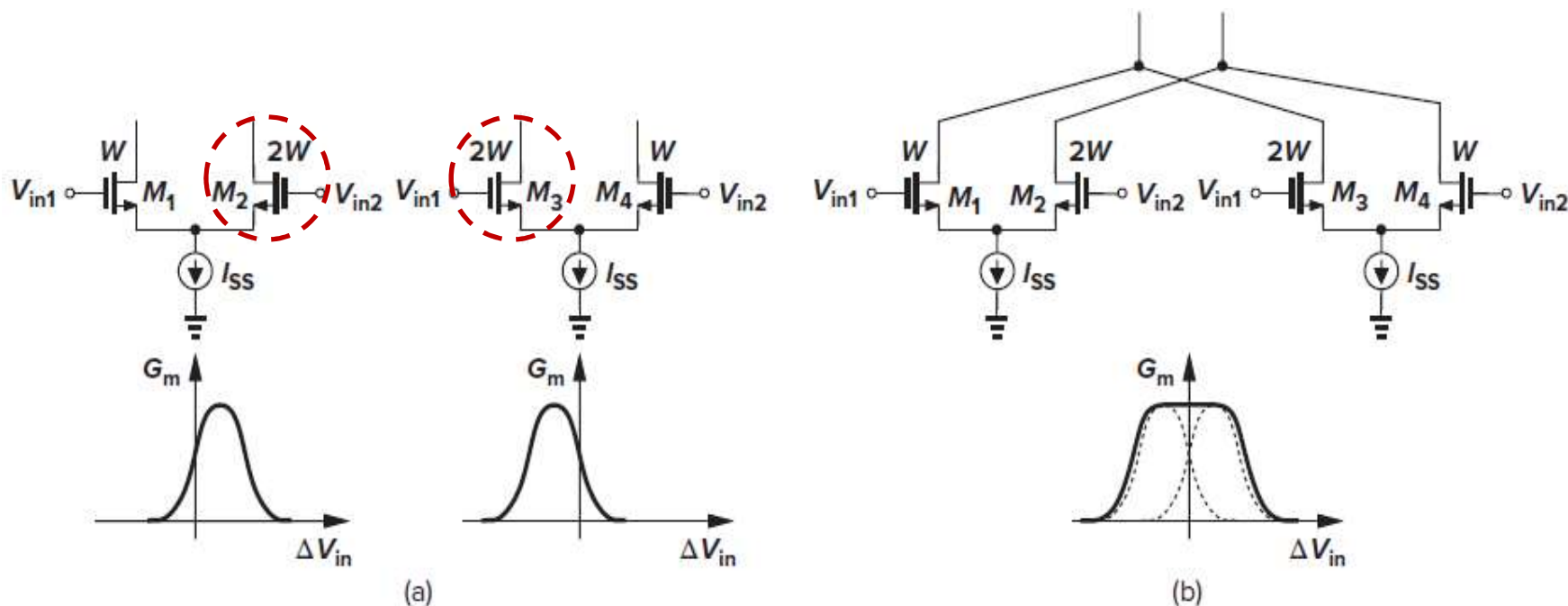
SCP: Source Couple Pair

$$G_m = \frac{g_m}{1 + g_m R_S}$$

$V_b$  is applied as an input-tracking control

MOSFET operating in the deep triode region

# Linearization Technique (2)

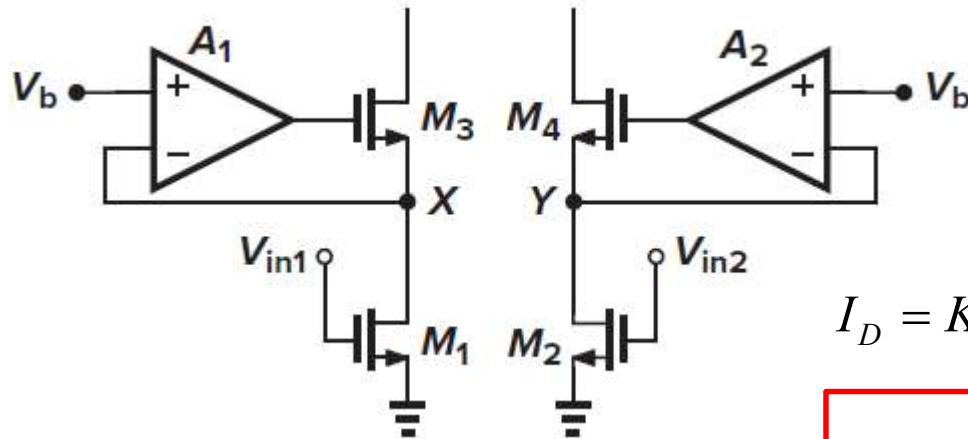


- Shift  $g_m$  by changing the input pair into unbalance conditions: left-shift and right-shift
- The composite final  $g_m$  has a flat shape if the optimal design is achieved
- Issue is the  $g_m$  flatness is PVT-sensitive



# Linearization Technique (3)

Differential pair using input devices operating in the triode region



$$I_D = K'_N \left( \frac{W}{L} \right) \left[ 2(V_{GS} - V_{TH})V_{DS} - V_{DS}^2 \right]$$

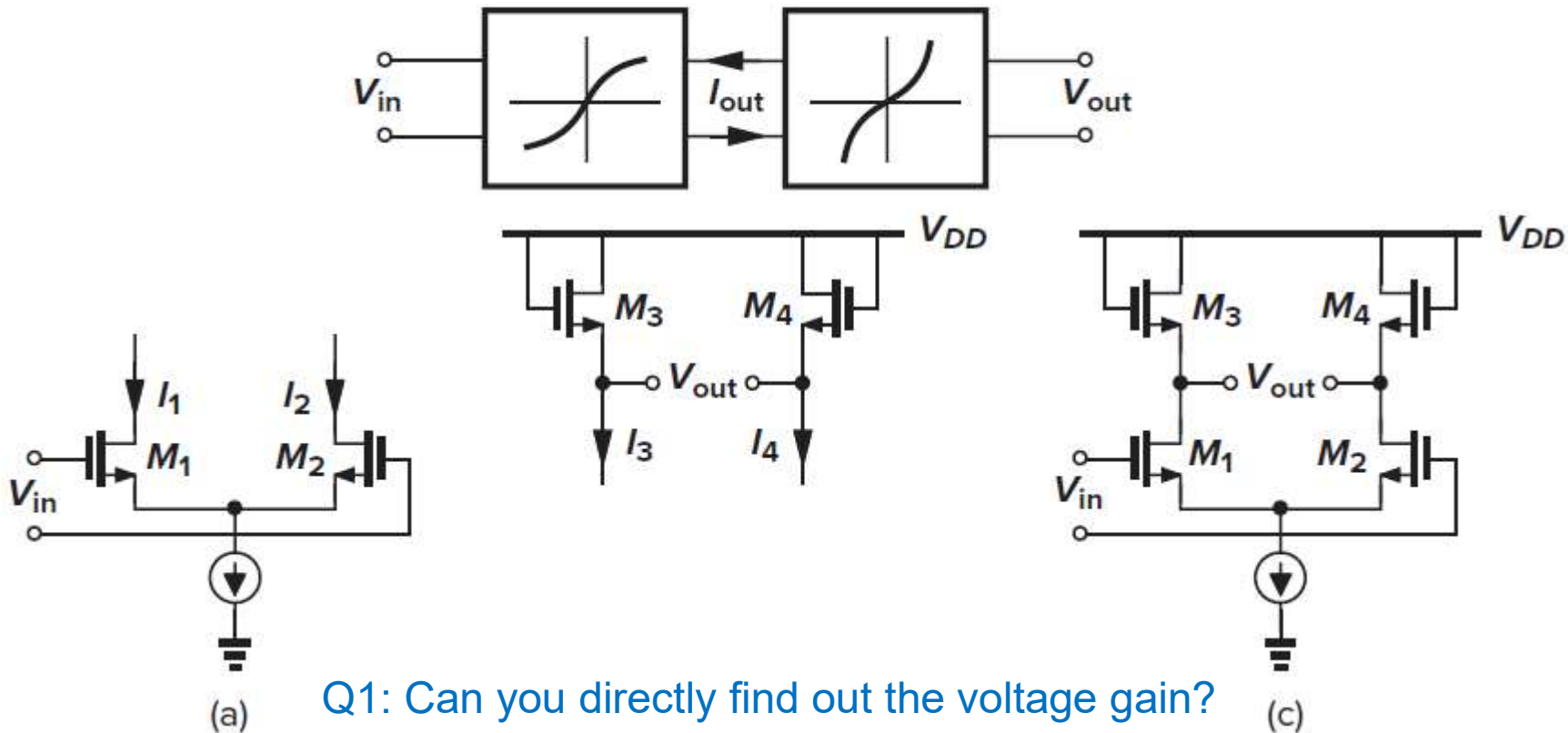
$$g_m = \frac{\partial I_D}{\partial V_{GS}} = 2K'_N \left( \frac{W}{L} \right) V_{DS}$$

Issues:

- $V_{DS}$  must be low enough to ensure that each input transistor remains in the triode region
- The input common-mode level must be tightly controlled, and it must track  $V_b$  so as to define  $I_{D1}$  and  $I_{D2}$
- Additional noise contribution from M3, M4, and two amplifiers
- $g_m$  may be too small since  $V_{DS}$  is small



# Linearization Technique (4)



$$\Delta I = I_1 - I_2 = g_{m1,2} \Delta V_{in}$$

$$\Delta V_{out} = \frac{\Delta I}{g_{m3,4}}$$

$$\Delta V_{out} = \frac{g_{m1,2}}{g_{m3,4}} \Delta V_{in}$$

# Linearization Technique (4)

$$V_{in1} - V_{in2} = V_{GS1} - V_{GS2}$$

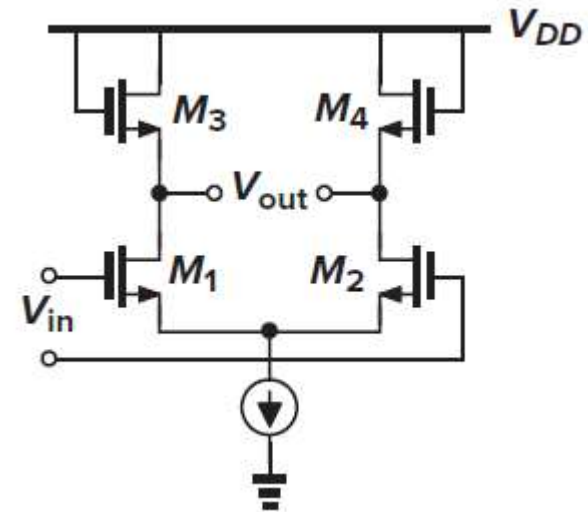
$$= \sqrt{\frac{2I_{D1}}{\mu_n C_{ox} \left(\frac{W}{L}\right)_{1,2}}} - \sqrt{\frac{2I_{D2}}{\mu_n C_{ox} \left(\frac{W}{L}\right)_{1,2}}}$$

$$V_{out} = V_{GS3} - V_{GS4}$$

$$= \sqrt{\frac{2I_3}{\mu_n C_{ox} \left(\frac{W}{L}\right)_{3,4}}} - \sqrt{\frac{2I_4}{\mu_n C_{ox} \left(\frac{W}{L}\right)_{3,4}}}$$

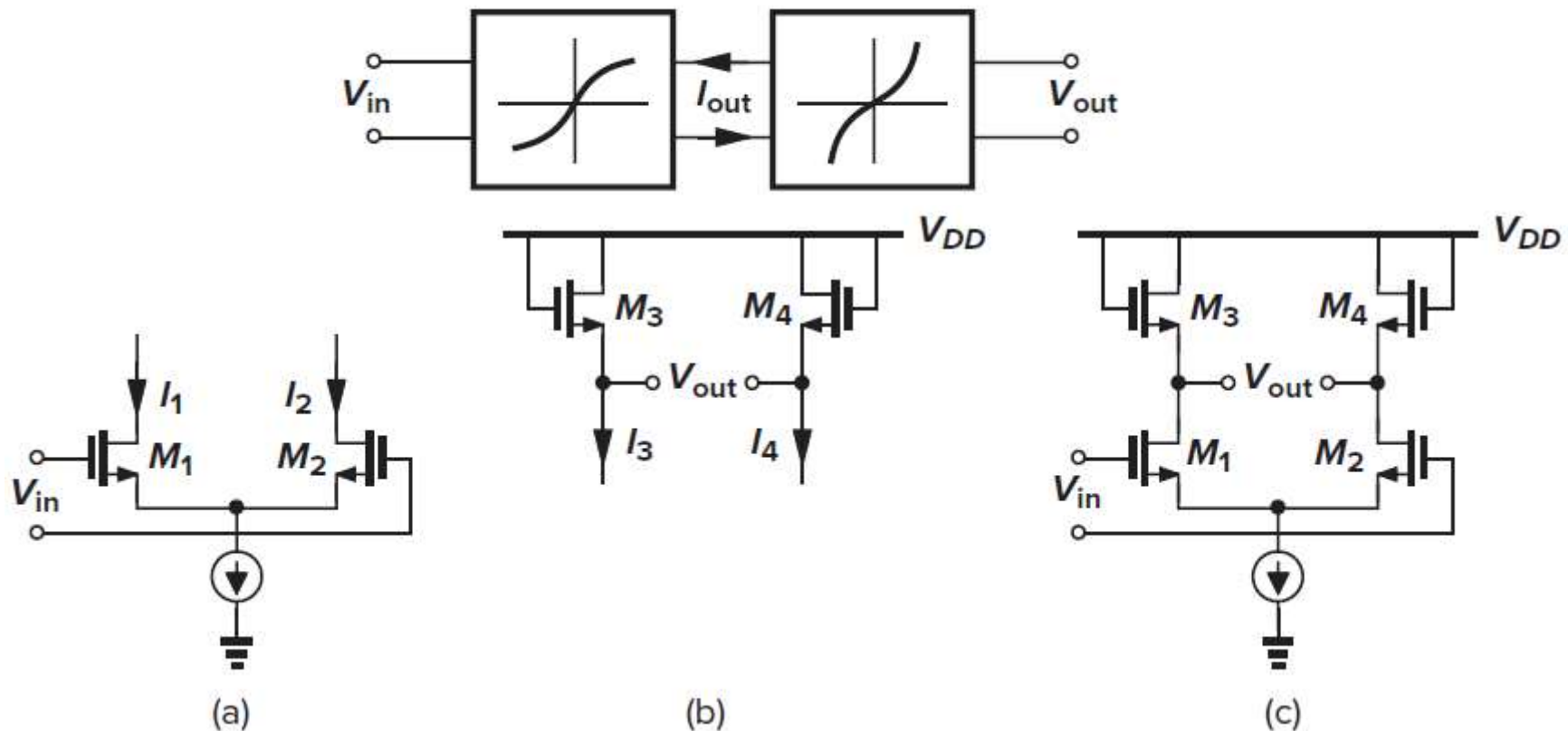
$$V_{out} = \sqrt{\frac{2I_{D1}}{\mu_n C_{ox} \left(\frac{W}{L}\right)_{3,4}}} - \sqrt{\frac{2I_{D2}}{\mu_n C_{ox} \left(\frac{W}{L}\right)_{3,4}}}$$

$$= \frac{1}{\sqrt{\left(\frac{W}{L}\right)_{3,4}}} (V_{in1} - V_{in2}) \sqrt{\left(\frac{W}{L}\right)_{1,2}}$$



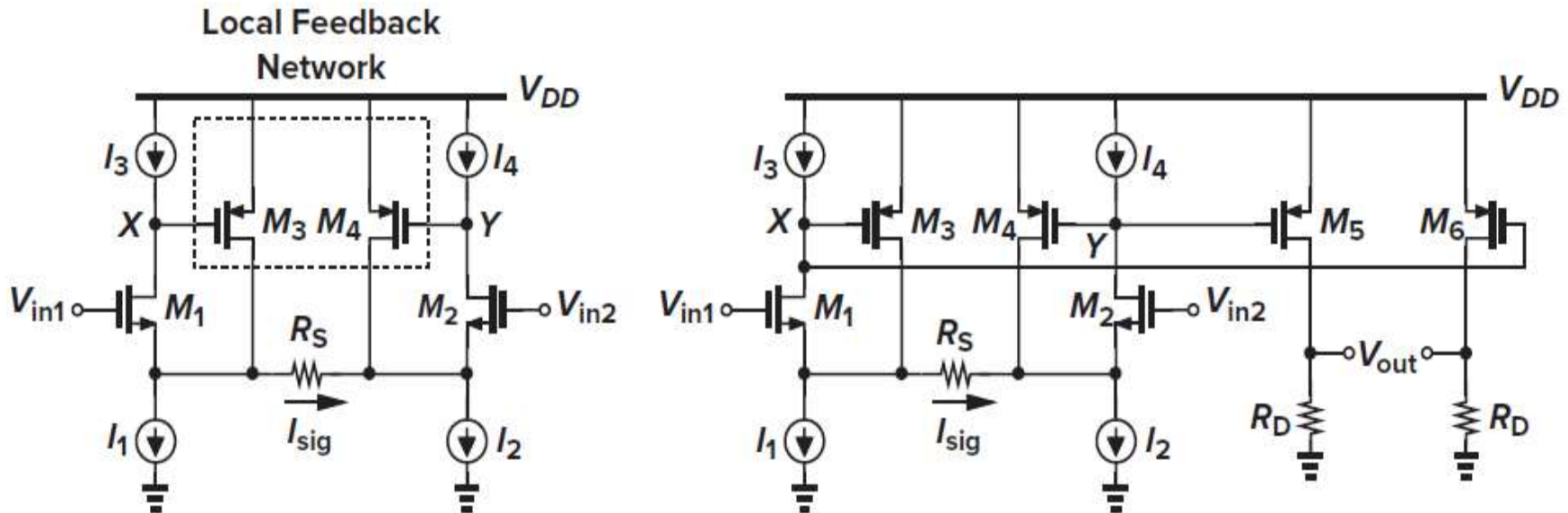
$$A_v = \sqrt{\frac{\left(\frac{W}{L}\right)_{1,2}}{\left(\frac{W}{L}\right)_{3,4}}}$$

# Linearization Technique (4)



- In practice, **body effect** and other nonidealities in short-channel devices will further give rise to nonlinearity in this circuit.
- Furthermore, as the differential input level increases, driving  $M_1$  or  $M_2$  into the triode region, the linearization is no longer hold and the gain drops sharply  
=> **Body effect can be solved by deep-nwell nMOSs**

# Linearization Technique (5)



$$V_{in1} = V_{cm} + V_{in} / 2$$

$$V_{in2} = V_{cm} - V_{in} / 2$$

$$\begin{aligned} V_{in} &= V_{GS1} + I_{sig} R_S - V_{GS2} \\ &= I_{sig} R_S, \text{ if } \underline{V_{GS1} = V_{GS2}} \end{aligned}$$

where  $I_3=I_4$ ,  $I_1=I_3+I_{M3}$ ;  $I_2=I_4+I_{M4}$

$$V_{out} = (I_6 - I_5)R_D$$

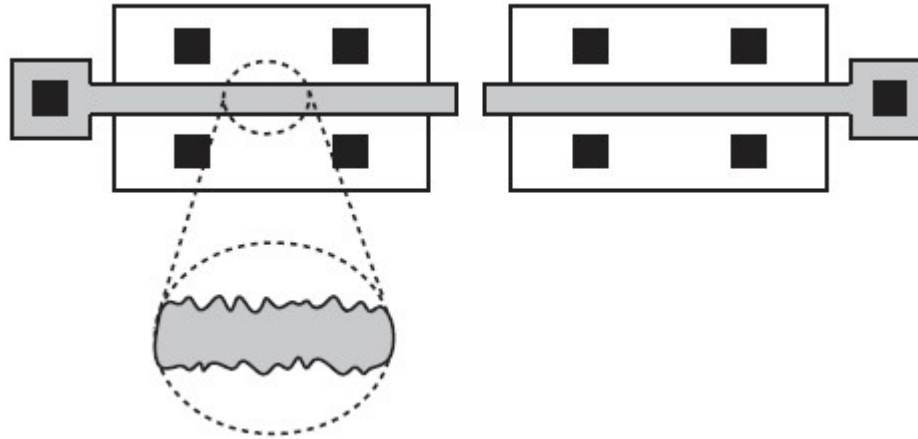
$$I_5 = I_{M4} \text{ and } I_6 = I_{M3}$$

$$\begin{aligned} V_{out} &= (I_{M3} - I_{M4}) R_D \\ &= I_{sig} R_D = \frac{R_D}{R_S} V_{in} \end{aligned}$$

## 這與課本不同

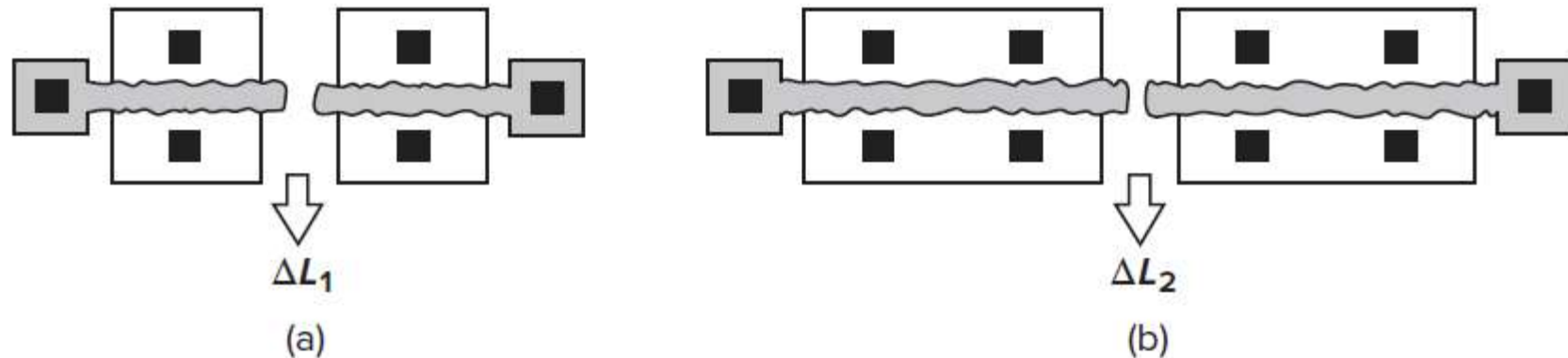
# Mismatch

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- Random mismatches due to microscopic variations in device dimensions (來自晶圓廠，在晶片製造上的非理想因素)
- Study of mismatch consists of two steps:
  - (1) To identify and formulate the mechanisms that lead to mismatch between devices, but it is not an easy work. Generally, it depends on the Foundry's process quality control
  - (2) To analyze the effect of device mismatches upon the performance of circuits

# Mismatch



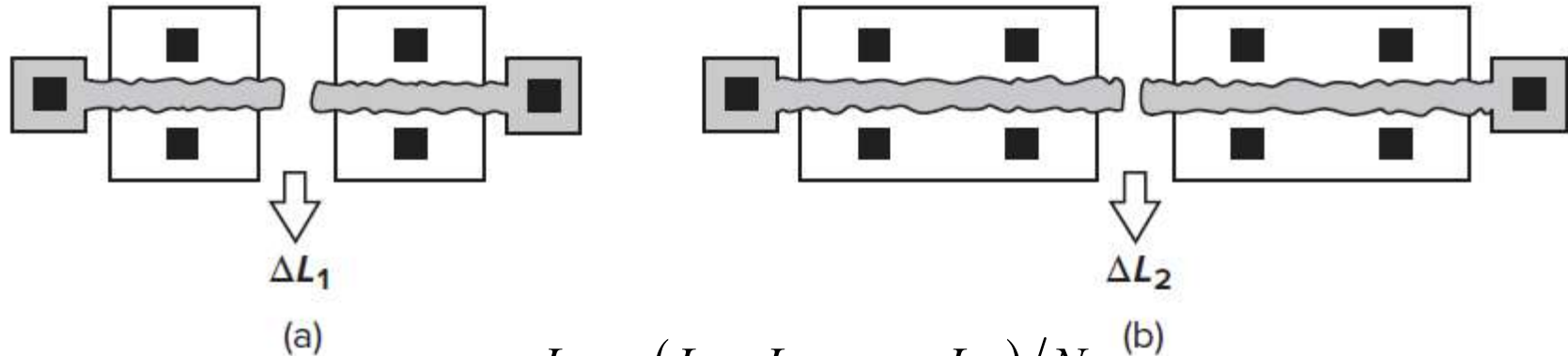
$$I_D = \frac{1}{2} \mu_n C_{ox} \left( \frac{W}{L} \right) (V_{GS} - V_{TH})^2$$

Mismatch issue on

- Current mirrors
- Bias voltages

- For two nominally-identical transistors
- Mismatches of  $\mu_n C_{ox}$ ,  $W$ ,  $L$ , and  $V_{TH}$  result in mismatches between drain currents (for a given  $V_{GS}$ ) or gate-source voltages (for a given drain current)
- Intuitively, larger devices exhibit smaller mismatches

# Mismatch - Concept



考量通道長度( $L$ )的變異:

$$L_i = L_0 + \Delta L_i$$

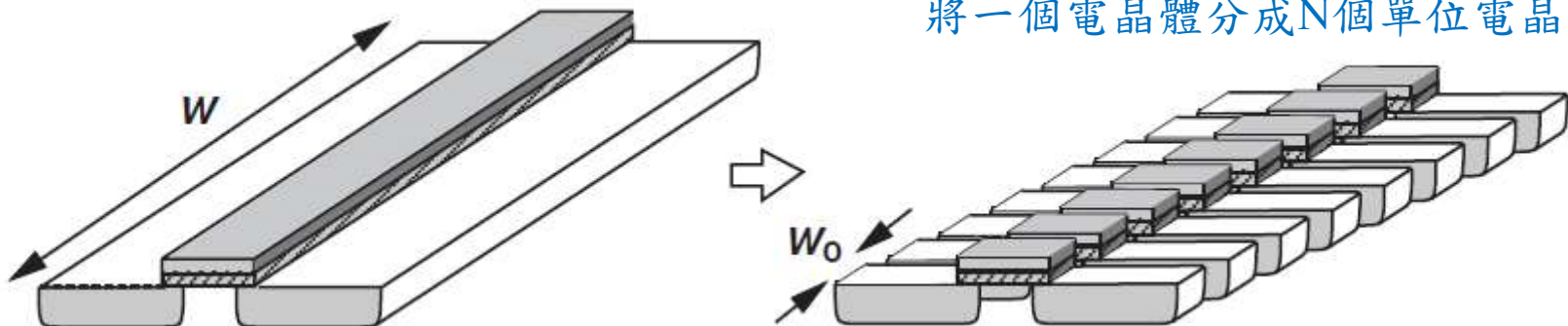
$\Delta L_i$  is a random variable

$$L_{eq} \approx (L_1 + L_2 + \dots + L_N) / N$$

$$\Delta L_{eq} \approx \frac{\sqrt{\Delta L_1^2 + \Delta L_2^2 + \dots + \Delta L_N^2}}{N} = \frac{\sqrt{N \Delta L_0^2}}{N} = \frac{\Delta L_0}{\sqrt{N}}$$

where  $\Delta L_0$  is the statistical variation of the length for a transistor with the length of  $L_0$

將一個電晶體分成 $N$ 個單位電晶體



# Random Variables

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Assume  $x_i$  is a zero mean random variable which is independent to each other

$$E[x_i] = 0, \text{ and } E[x_i^2] = \sigma^2, \forall i$$

Assume a function  $y = x_1 + x_2 + x_3 + x_4$ ,

$$E[y] = E[x_1] + E[x_2] + E[x_3] + E[x_4] = 0$$

$$\sigma_y^2 = E[y^2] = E[x_1^2] + E[x_2^2] + E[x_3^2] + E[x_4^2] = 4\sigma^2$$

$$\Rightarrow \sigma_y = 2\sigma$$

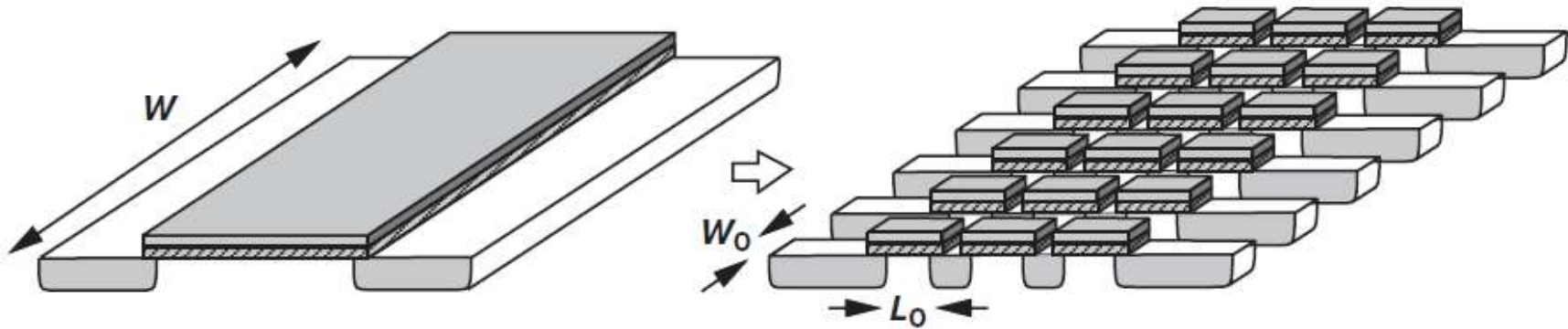
Considering two new random variables,

$$y_1 = \sum_{i=1}^N x_i \Rightarrow \sigma_{y_1} = \sqrt{N}\sigma$$

$$y_2 = \frac{1}{N} \sum_{i=1}^N x_i \Rightarrow \sigma_{y_2}^2 = \frac{1}{N^2} \sum_{i=1}^N E[x_i^2] = \frac{\sigma^2}{N} \Rightarrow \sigma_{y_2} = \frac{\sigma}{\sqrt{N}}$$



# Mismatch

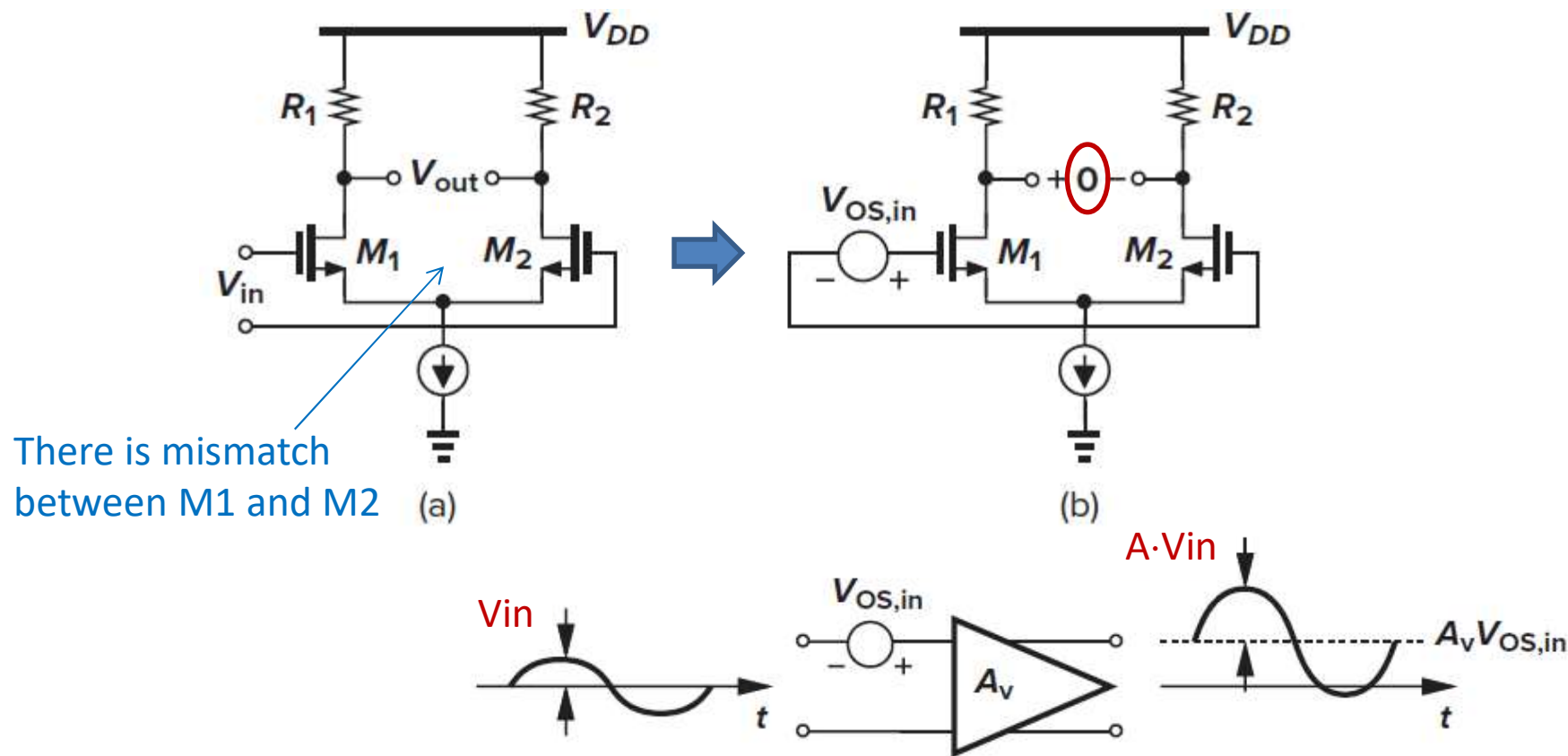


$$\Delta V_{TH} = \frac{A_{V_{TH}}}{\sqrt{WL}}$$

$$\frac{\Delta \beta}{\beta} = \Delta \left( \mu C_{ox} \frac{W}{L} \right) / \beta = \frac{A_{\beta}}{\sqrt{WL}}$$

- We postulate that  $\beta = \mu C_{ox}(W/L)$  and  $V_{TH}$  suffer from less mismatch if the device area increases (**larger transistor dimension**)
- For given  $W_0$  and  $L_0$ , as the number of unit transistors increases,  $\beta$  and  $V_{TH}$  experience greater averaging, leading to smaller mismatch between two large transistors

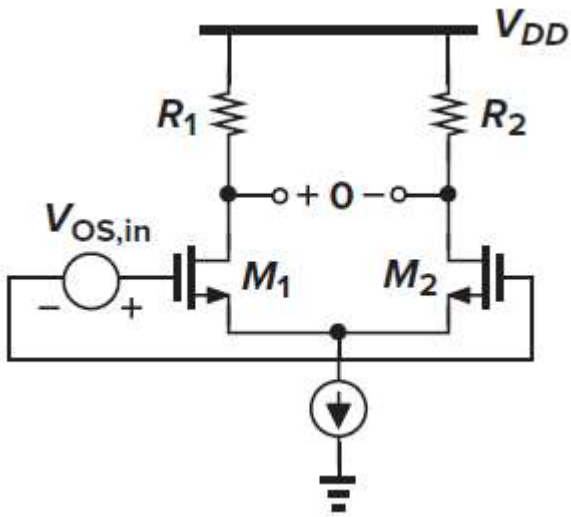
# Mismatch of Input Pair



- **DC Offset ( $V_{OS}$ )**

- Two conditions: (1)  $V_{in}=0$  but  $V_{out} \neq 0$ ; (2)  $V_{in} \neq 0$  but  $V_{out}=0$
- Figure (b) presents the input-referred offset voltage ( $V_{OS,in}$ ), caused by the device mismatch

# Input-Referred Offset



$$\begin{aligned}
 V_{OS,in} &= V_{GS1} - V_{GS2} \\
 &= \sqrt{\frac{2I_{D1}}{\mu_n C_{ox} \left(\frac{W}{L}\right)_1}} + V_{TH1} - \sqrt{\frac{2I_{D2}}{\mu_n C_{ox} \left(\frac{W}{L}\right)_2}} - V_{TH2} \\
 &= \sqrt{\frac{2}{\mu_n C_{ox}}} \left[ \sqrt{\frac{I_D}{W/L}} - \sqrt{\frac{I_D + \Delta I_D}{W/L + \Delta(W/L)}} \right] - \Delta V_{TH} \\
 &= \sqrt{\frac{2I_D}{\mu_n C_{ox} (W/L)}} \left[ 1 - \sqrt{\frac{1 + \Delta I_D/I_D}{1 + \Delta(W/L)/(W/L)}} \right] - \Delta V_{TH}
 \end{aligned}$$

$$V_{TH1} = V_{TH}, V_{TH2} = V_{TH} + \Delta V_{TH}$$

$$\left(\frac{W}{L}\right)_1 = \frac{W}{L}, \left(\frac{W}{L}\right)_2 = \frac{W}{L} + \Delta\left(\frac{W}{L}\right)$$

$$R_1 = R_D, R_2 = R_D + \Delta R$$

$$\text{Assume } \lambda = \gamma = 0, \Delta(\mu_n C_{ox}) = 0$$

$$V_{out} = 0, I_{D1} R_1 = I_{D2} R_2$$

$$I_{D1} = I_D, I_{D2} = I_D + \Delta I_D$$

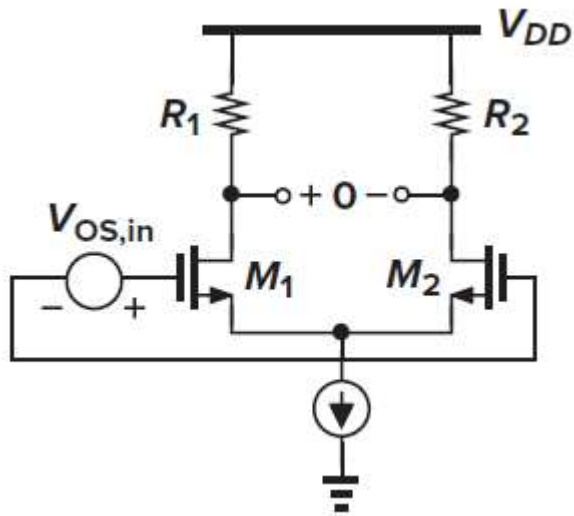
Assume  $\Delta I_D/I_D$  and  $\Delta(W/L)/(W/L) \ll 1$ ,

for  $\varepsilon \ll 1$ ,  $\sqrt{1+\varepsilon} \approx 1 + \varepsilon/2$

$$V_{OS,in} = \sqrt{\frac{2I_D}{\mu_n C_{ox} (W/L)}} \left\{ 1 - \left( 1 + \frac{\Delta I_D}{2I_D} \right) \left( 1 - \frac{\Delta(W/L)}{2(W/L)} \right) \right\} - \Delta V_{TH}$$

$$V_{OS,in} = \sqrt{\frac{2I_D}{\mu_n C_{ox} (W/L)}} \left[ \frac{-\Delta I_D}{2I_D} + \frac{\Delta(W/L)}{2(W/L)} \right] - \Delta V_{TH}$$

# Input-Referred Offset



$$\Delta I_D / I_D \approx -\Delta R_D / R_D$$

$$V_{OS,in} = \frac{1}{2} \sqrt{\frac{2I_D}{\mu_n C_{ox} (W/L)}} \left[ \frac{\Delta R_D}{R_D} + \frac{\Delta(W/L)}{(W/L)} \right] - \Delta V_{TH}$$

$$= \frac{V_{GS} - V_{TH}}{2} \left[ \frac{\Delta R_D}{R_D} + \frac{\Delta(W/L)}{(W/L)} \right] - \Delta V_{TH}$$

$\Rightarrow V_{OS,in}$  is also a random variable

$$V_{OS,in}^2 = \left( \frac{V_{GS} - V_{TH}}{2} \right)^2 \left[ \left( \frac{\Delta R_D}{R_D} \right)^2 + \left( \frac{\Delta(W/L)}{(W/L)} \right)^2 \right] + \Delta V_{TH}^2$$

$$\sigma_{OS,in}^2 = \left( \frac{V_{GS} - V_{TH}}{2} \right)^2 \left[ \sigma \left( \frac{\Delta R_D}{R_D} \right)^2 + \sigma \left( \frac{\Delta(W/L)}{(W/L)} \right)^2 \right] + \sigma_{V_{TH}}^2$$

Q: From this result, to get a small offset, how to design  $V_{GS} - V_{TH}$ ?

# Mismatch of Current Mirror

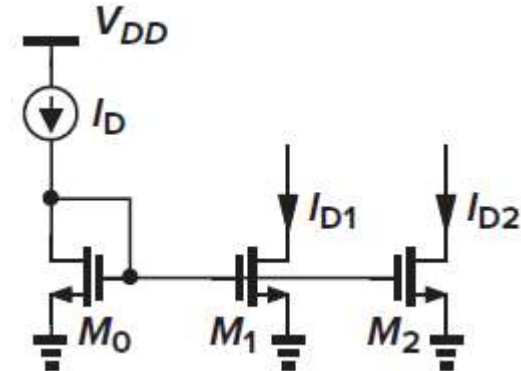
Recall  $y = f(x_1, x_2, \dots)$

$$\Delta y = \frac{\partial f}{\partial x_1} \Delta x_1 + \frac{\partial f}{\partial x_2} \Delta x_2 + \dots$$

$$\Delta I_D = \frac{\partial I_D}{\partial (W/L)} \Delta \left( \frac{W}{L} \right) + \frac{\partial I_D}{\partial (V_{GS} - V_{TH})} \Delta (V_{GS} - V_{TH})$$

$$\Delta I_D = \frac{1}{2} \mu_n C_{ox} (V_{GS} - V_{TH})^2 \Delta \left( \frac{W}{L} \right) - \mu_n C_{ox} \left( \frac{W}{L} \right) (V_{GS} - V_{TH}) \Delta V_{TH}$$

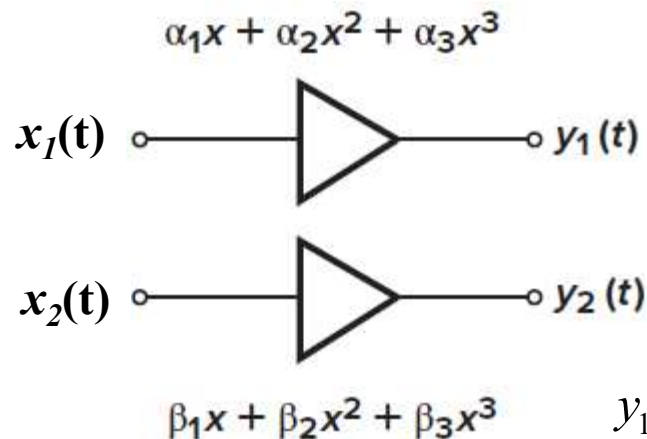
$$\frac{\Delta I_D}{I_D} = \frac{\Delta (W/L)}{W/L} - \underbrace{\left( \frac{V_{GS} - V_{TH}}{2} \right)^{-1}} \Delta V_{TH}$$



- Different from  $V_{OS,in}$ , the current mismatch is inversely proportional to gate-overdrive voltage ( $V_{GS} - V_{TH}$ )

# Even-Order Distortion: Mismatch

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$$y_1 - y_2 = (\alpha_1 x_1 - \beta_1 x_2) + (\alpha_2 x_1^2 - \beta_2 x_2^2) + (\alpha_3 x_1^3 - \beta_3 x_2^3)$$

Assume  $x_1 = x$  and  $x_2 = -x$ ,

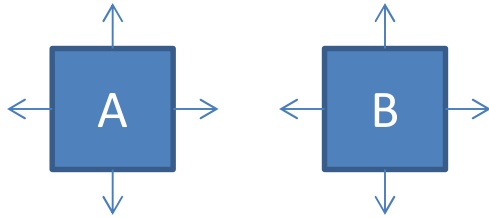
if  $\alpha_i \neq \beta_i, \forall i$

$$y_d = y_1 - y_2 = (\alpha_1 + \beta_1)x + \underline{(\alpha_2 - \beta_2)x^2} + (\alpha_3 + \beta_3)x^3$$

- Single-ended signals have tones of 2<sup>nd</sup>, 3<sup>rd</sup>, 4<sup>th</sup>, ...
- Fully differential circuits ideally have only odd-order tones
- However, **mismatch causes even-order tones in differential signals**
- In addition, **the (thermal) gradient also contributes mismatch**

# Gradient: Systematic Issue

Random mismatch



Thermal gradient

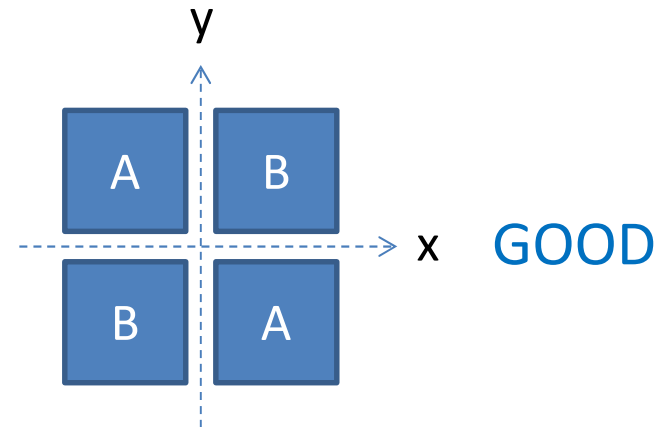


Gradient is a deterministic error which causes additional mismatch errors

Layout pattern for gradient



BAD

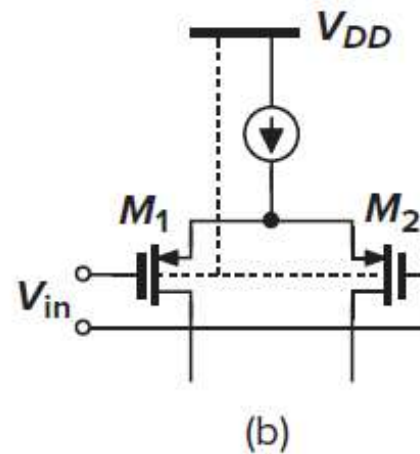
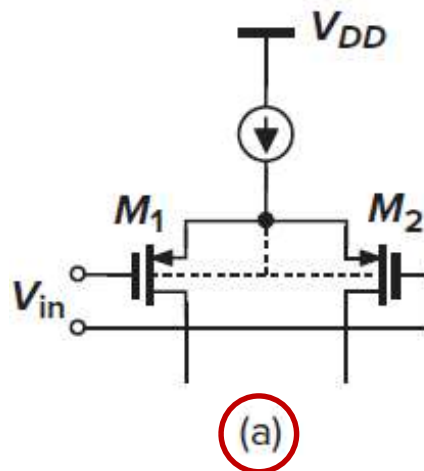


The solution is **common-centroid** layout patterns

# CMRR Considerations

$$A_{CM-DM} = \frac{\Delta V_{OS,out}}{\Delta V_{CM,in}}, \quad A_{DM} = \frac{\Delta V_{OS,out}}{\Delta V_{OS,in}}$$

$$CMRR = \frac{A_{DM}}{A_{CM-DM}} = \frac{A_{DM}}{\frac{\Delta V_{OS,out}}{\Delta V_{CM,in}}} = \frac{\Delta V_{CM,in}}{\frac{\Delta V_{OS,out}}{A_{DM}}} = \frac{\Delta V_{CM,in}}{\Delta V_{OS,in}} \quad \text{Less mismatch, higher CMRR}$$



In Fig. (a), body effect is eliminated and the threshold voltages of  $M1$  and  $M2$  are independent of the input CM level. *But, large layout area is introduced!!*

In Fig. (b), if they suffer from mismatches in their body effect coefficients, the input offset voltage varies with the input CM level